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# FDS4897AC

## Dual N & P-Channel PowerTrench® MOSFET

N-Channel: 40 V, 6.1 A, 26 mΩ P-Channel: -40 V, -5.2 A, 39 mΩ

### Features

Q1: N-Channel

- Max  $r_{DS(on)}$  = 26 mΩ at  $V_{GS} = 10$  V,  $I_D = 6.1$  A
- Max  $r_{DS(on)}$  = 31 mΩ at  $V_{GS} = 4.5$  V,  $I_D = 5.6$  A

Q2: P-Channel

- Max  $r_{DS(on)}$  = 39 mΩ at  $V_{GS} = -10$  V,  $I_D = -5.2$  A
- Max  $r_{DS(on)}$  = 65 mΩ at  $V_{GS} = -4.5$  V,  $I_D = -4.1$  A
- 100% UIL Tested
- RoHS Compliant

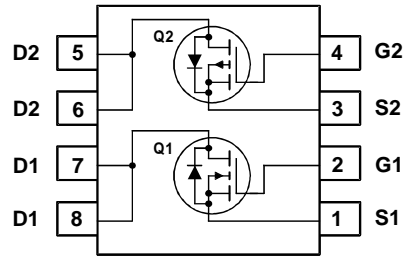
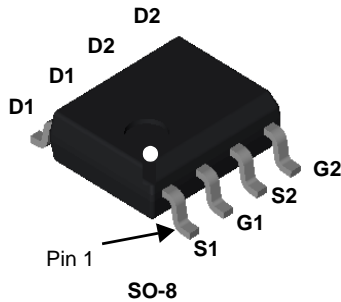


### General Description

These dual N- and P-Channel MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench® process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

### Applications

- Inverter
- Power Supplies



### MOSFET Maximum Ratings $T_A = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Q1	Q2	Units
$V_{DS}$	Drain to Source Voltage	40	-40	V
$V_{GS}$	Gate to Source Voltage	$\pm 20$	$\pm 20$	V
$I_D$	Drain Current - Continuous	6.1	-5.2	A
	- Pulsed	24	-24	
$P_D$	Power Dissipation for Dual Operation	2.0		W
	Power Dissipation for Single Operation	$T_A = 25^\circ\text{C}$ (Note 1a)		
		$T_A = 25^\circ\text{C}$ (Note 1b)		
$E_{AS}$	Single Pulse Avalanche Energy (Note 3)	37	73	mJ
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to +150		$^\circ\text{C}$

### Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case, (Note 1)	40	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, (Note 1a)	78	

### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDS4897AC	FDS4897AC	SO-8	13"	12 mm	2500 units

### Electrical Characteristics $T_J = 25\text{ }^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Type	Min	Typ	Max	Units
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#### Off Characteristics

$BV_{DSS}$	Drain to Source Breakdown Voltage	$I_D = 250\text{ }\mu\text{A}$ , $V_{GS} = 0\text{ V}$ $I_D = -250\text{ }\mu\text{A}$ , $V_{GS} = 0\text{ V}$	Q1 Q2	40 -40			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250\text{ }\mu\text{A}$ , referenced to $25\text{ }^\circ\text{C}$ $I_D = -250\text{ }\mu\text{A}$ , referenced to $25\text{ }^\circ\text{C}$	Q1 Q2		37 -32		mV/ $^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 32\text{ V}$ , $V_{GS} = 0\text{ V}$ $V_{DS} = -32\text{ V}$ , $V_{GS} = 0\text{ V}$	Q1 Q2			1 -1	$\mu\text{A}$
$I_{GSS}$	Gate to Source Leakage Current	$V_{GS} = \pm 20\text{ V}$ , $V_{DS} = 0\text{ V}$	Q1 Q2			$\pm 100$ $\pm 100$	nA nA

#### On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 250\text{ }\mu\text{A}$ $V_{GS} = V_{DS}$ , $I_D = -250\text{ }\mu\text{A}$	Q1 Q2	1.5 -1.5	2.0 -2.0	3.0 -3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250\text{ }\mu\text{A}$ , referenced to $25\text{ }^\circ\text{C}$ $I_D = -250\text{ }\mu\text{A}$ , referenced to $25\text{ }^\circ\text{C}$	Q1 Q2		-6 6		mV/ $^\circ\text{C}$
$r_{DS(on)}$	Static Drain to Source On Resistance	$V_{GS} = 10\text{ V}$ , $I_D = 6.1\text{ A}$ $V_{GS} = 4.5\text{ V}$ , $I_D = 5.6\text{ A}$ $V_{GS} = 10\text{ V}$ , $I_D = 6.1\text{ A}$ , $T_J = 125\text{ }^\circ\text{C}$	Q1		20 24 30	26 31 39	m $\Omega$
		$V_{GS} = -10\text{ V}$ , $I_D = -5.2\text{ A}$ $V_{GS} = -4.5\text{ V}$ , $I_D = -4.1\text{ A}$ $V_{GS} = -10\text{ V}$ , $I_D = -5.2\text{ A}$ , $T_J = 125\text{ }^\circ\text{C}$	Q2		28 45 41	39 65 57	
$g_{FS}$	Forward Transconductance	$V_{DD} = 5\text{ V}$ , $I_D = 6.1\text{ A}$ $V_{DD} = -5\text{ V}$ , $I_D = -5.2\text{ A}$	Q1 Q2		24 14		S

#### Dynamic Characteristics

$C_{iss}$	Input Capacitance	Q1 $V_{DS} = 20\text{ V}$ , $V_{GS} = 0\text{ V}$ , $f = 1\text{ MHz}$	Q1 Q2		795 765	1055 1015	pF
$C_{oss}$	Output Capacitance	Q2	Q1 Q2		95 135	130 180	pF
$C_{riss}$	Reverse Transfer Capacitance	$V_{DS} = -20\text{ V}$ , $V_{GS} = 0\text{ V}$ , $f = 1\text{ MHz}$	Q1 Q2		65 80	100 120	pF
$R_g$	Gate Resistance		Q1 Q2		1.7 3.6		$\Omega$

#### Switching Characteristics

$t_{d(on)}$	Turn-On Delay Time	Q1 $V_{DD} = 20\text{ V}$ , $I_D = 6.1\text{ A}$ , $V_{GS} = 10\text{ V}$ , $R_{GEN} = 6\text{ }\Omega$	Q1 Q2		6 8	12 15	ns
$t_r$	Rise Time	$V_{GS} = 10\text{ V}$ , $R_{GEN} = 6\text{ }\Omega$	Q1 Q2		2 3	10 10	ns
$t_{d(off)}$	Turn-Off Delay Time	Q2 $V_{DD} = -20\text{ V}$ , $I_D = -5.2\text{ A}$ , $V_{GS} = -10\text{ V}$ , $R_{GEN} = 6\text{ }\Omega$	Q1 Q2		17 17	30 30	ns
$t_f$	Fall Time	$V_{GS} = -10\text{ V}$ , $R_{GEN} = 6\text{ }\Omega$	Q1 Q2		2 3	10 10	ns
$Q_{g(TOT)}$	Total Gate Charge	Q1 $V_{GS} = 10\text{ V}$ , $V_{DD} = 20\text{ V}$ , $I_D = 6.1\text{ A}$	Q1 Q2		15 15	21 20	nC
$Q_{gs}$	Gate to Source Charge	Q1 Q2	Q1 Q2		2.5 2.6		nC
$Q_{gd}$	Gate to Drain "Miller" Charge	$V_{GS} = -10\text{ V}$ , $V_{DD} = -20\text{ V}$ , $I_D = -5.2\text{ A}$	Q1 Q2		2.9 3.2		nC

## Electrical Characteristics $T_J = 25\text{ }^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Type	Min	Typ	Max	Units
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### Drain-Source Diode Characteristics

$V_{SD}$	Source to Drain Diode Forward Voltage	$V_{GS} = 0\text{ V}, I_S = 1.3\text{ A}$ (Note 2)	Q1		0.75	1.2	V
		$V_{GS} = 0\text{ V}, I_S = -1.3\text{ A}$ (Note 2)	Q2		-0.76	-1.2	
$t_{rr}$	Reverse Recovery Time	Q1 $I_F = 6.1\text{ A}, di/dt = 100\text{ A/s}$	Q1		17	31	ns
			Q2		20	36	
$Q_{rr}$	Reverse Recovery Charge	Q2 $I_F = -5.2\text{ A}, di/dt = 100\text{ A/s}$	Q1		7	15	nC
			Q2		10	20	

**Notes:**

1:  $R_{\theta JA}$  is determined with the device mounted on a  $1\text{ in}^2$  pad 2 oz copper pad on a  $1.5 \times 1.5\text{ in.}$  board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a)  $78\text{ }^\circ\text{C/W}$  when mounted on a  $1\text{ in}^2$  pad of 2 oz copper



b)  $135\text{ }^\circ\text{C/W}$  when mounted on a minimum pad

2: Pulse Test: Pulse Width  $< 300\text{ }\mu\text{s}$ , Duty cycle  $< 2.0\%$ .

3: Starting  $T_J = 25\text{ }^\circ\text{C}$ , N-ch:  $L = 3\text{ mH}$ ,  $I_{AS} = 5\text{ A}$ ,  $V_{DD} = 40\text{ V}$ ,  $V_{GS} = 10\text{ V}$ ; P-ch:  $L = 3\text{ mH}$ ,  $I_{AS} = -7\text{ A}$ ,  $V_{DD} = -40\text{ V}$ ,  $V_{GS} = -10\text{ V}$ .

**Typical Characteristics (Q1 N-Channel)**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted

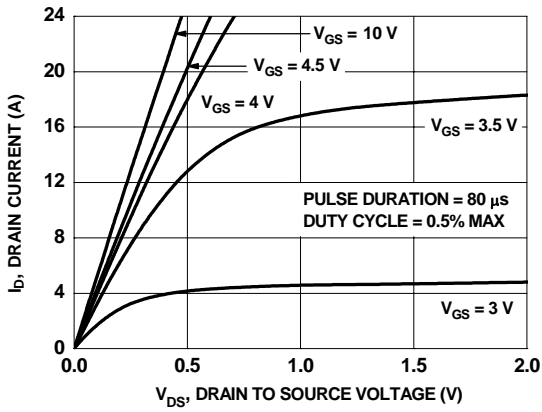


Figure 1. On Region Characteristics

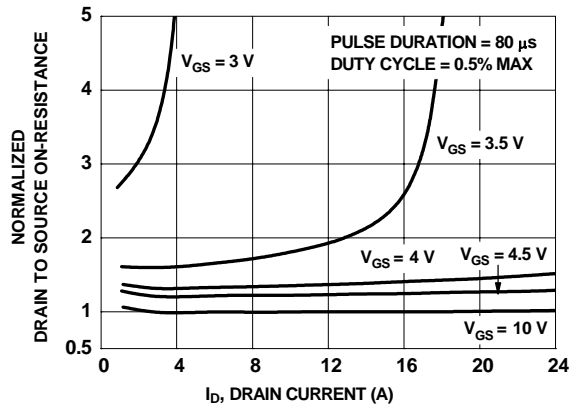


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

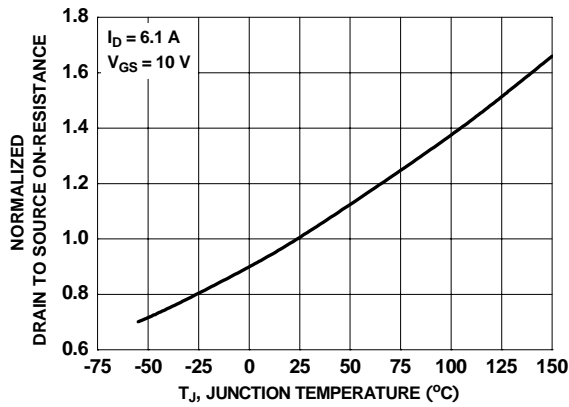


Figure 3. Normalized On Resistance vs Junction Temperature

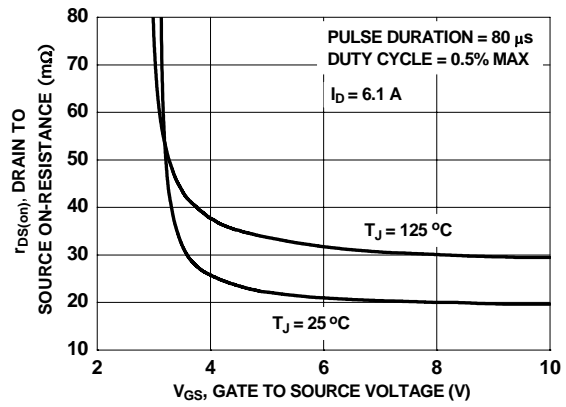


Figure 4. On-Resistance vs Gate to Source Voltage

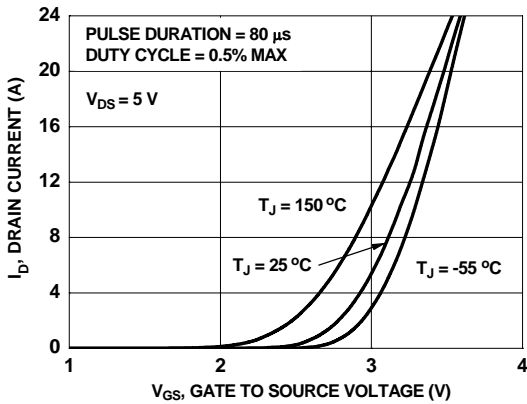


Figure 5. Transfer Characteristics

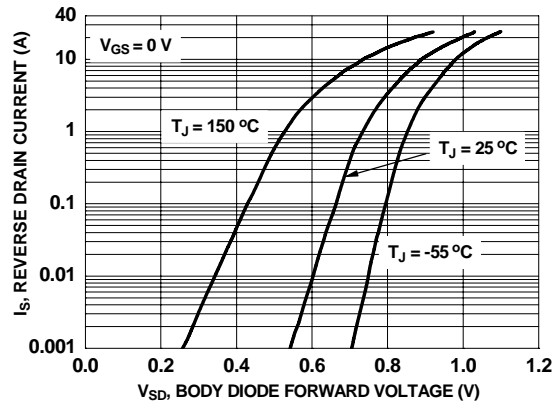
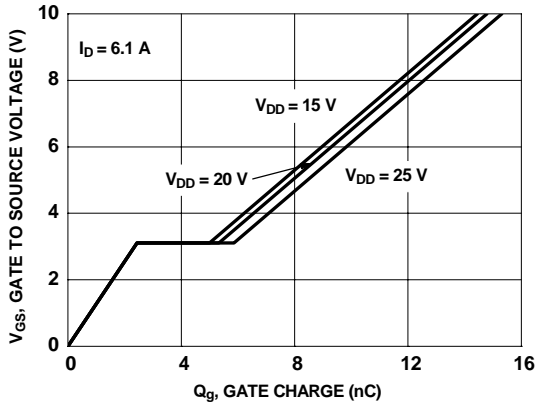
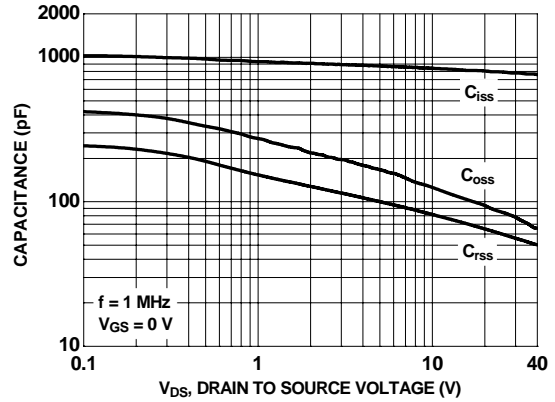


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

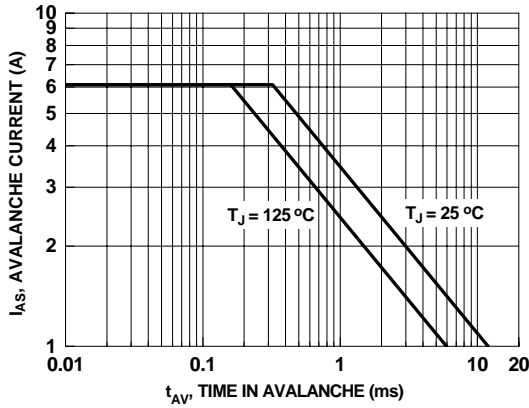
**Typical Characteristics (Q1 N-Channel)**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted



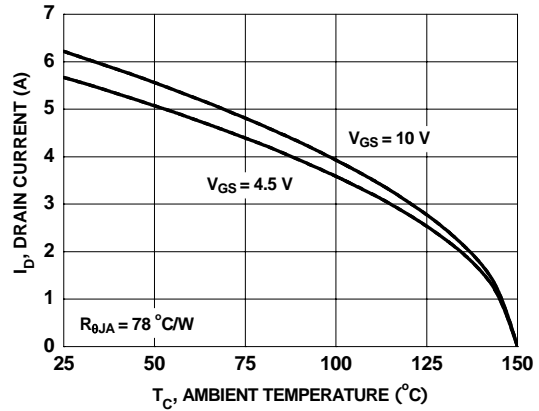
**Figure 7. Gate Charge Characteristics**



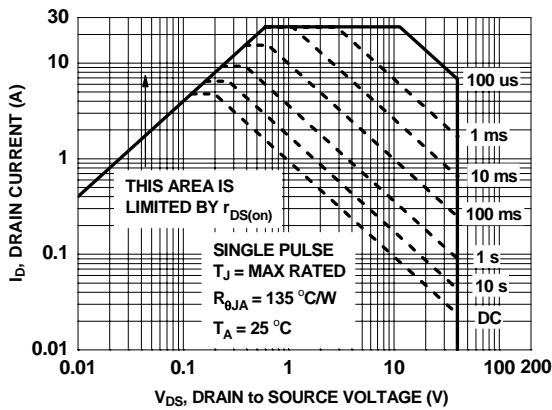
**Figure 8. Capacitance vs Drain to Source Voltage**



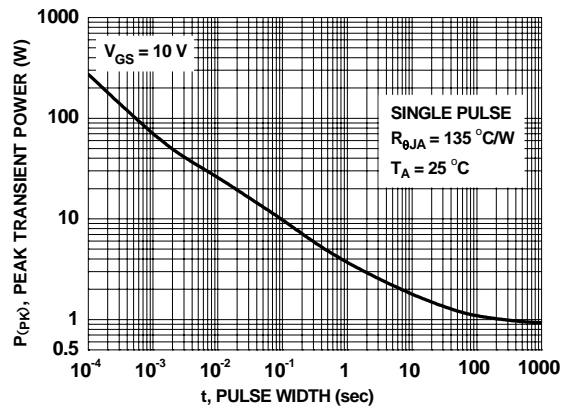
**Figure 9. Unclamped Inductive Switching Capability**



**Figure 10. Maximum Continuous Drain Current vs Ambient Temperature**

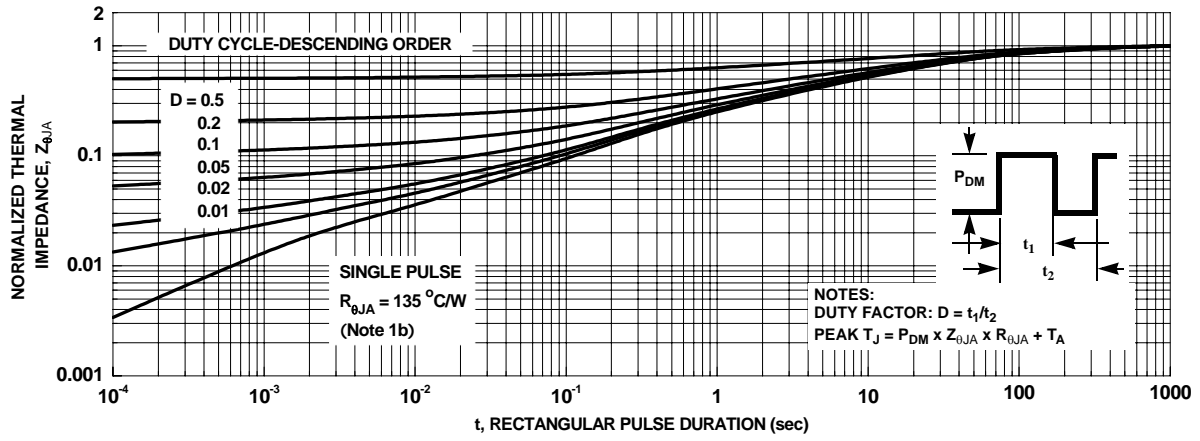


**Figure 11. Forward Bias Safe Operating Area**



**Figure 12. Single Pulse Maximum Power Dissipation**

**Typical Characteristics (Q1 N-Channel)**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted



**Figure 13. Junction-to-Ambient Transient Thermal Response Curve**

**Typical Characteristics (Q2 P-Channel)**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted

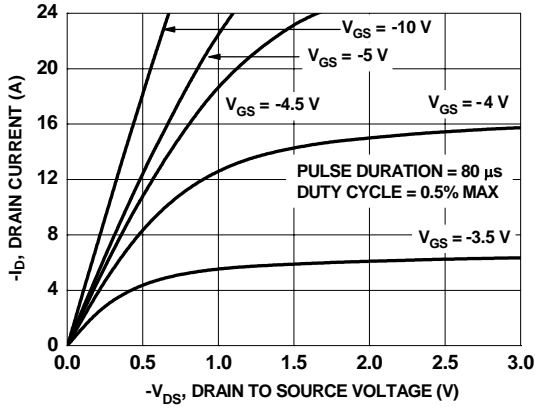


Figure 15. On-Region Characteristics

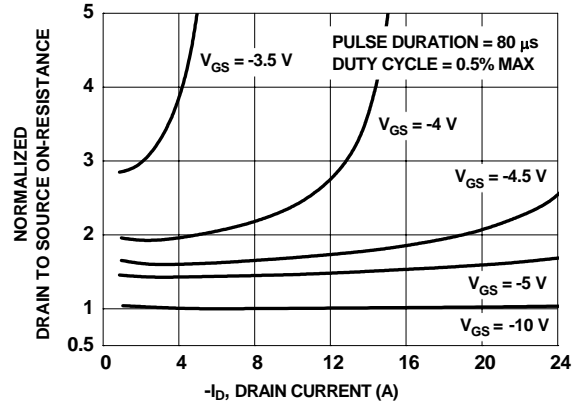


Figure 16. Normalized on-Resistance vs Drain Current and Gate Voltage

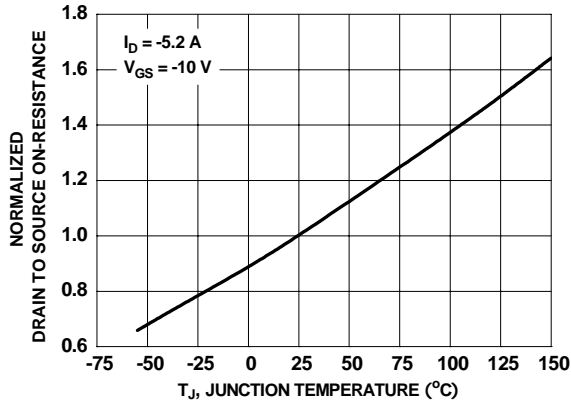


Figure 17. Normalized On-Resistance vs Junction Temperature

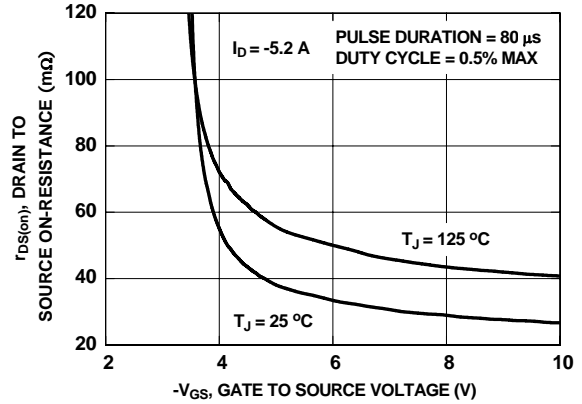


Figure 18. On-Resistance vs Gate to Source Voltage

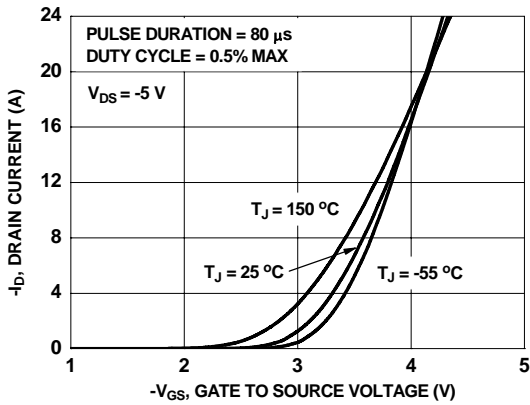


Figure 19. Transfer Characteristics

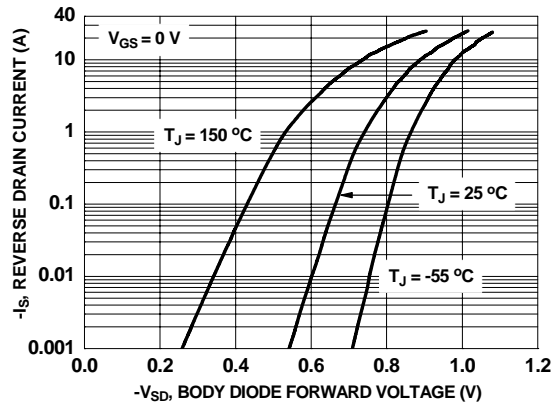
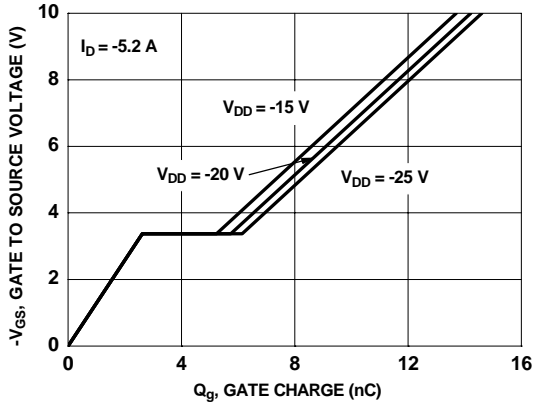


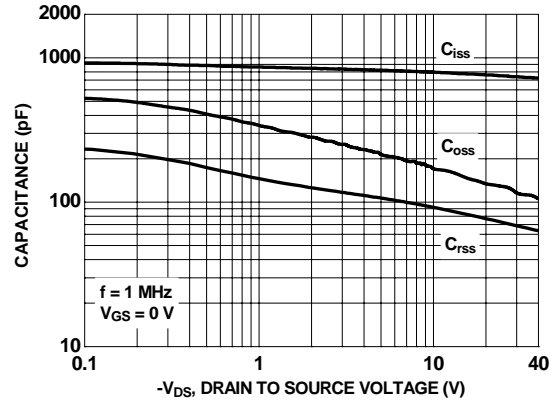
Figure 20. Source to Drain Diode Forward Voltage vs Source Current



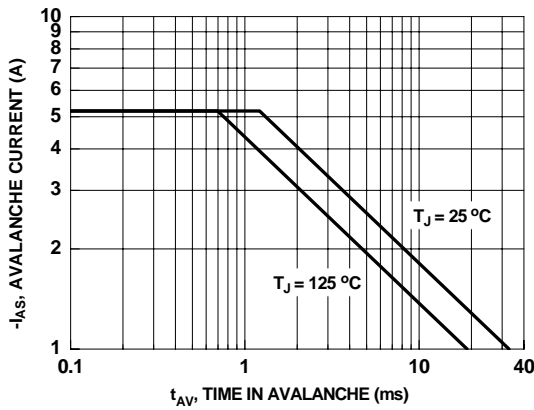
**Typical Characteristics (Q2 P-Channel)**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted



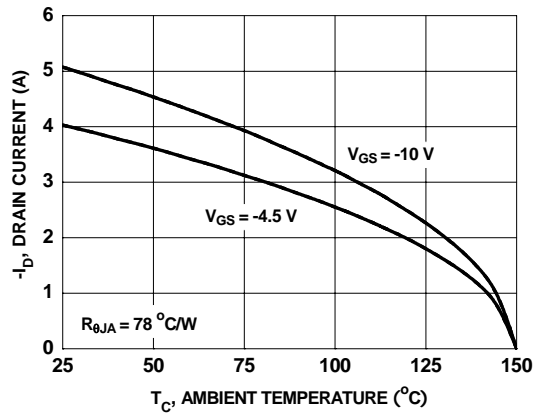
**Figure 21. Gate Charge Characteristics**



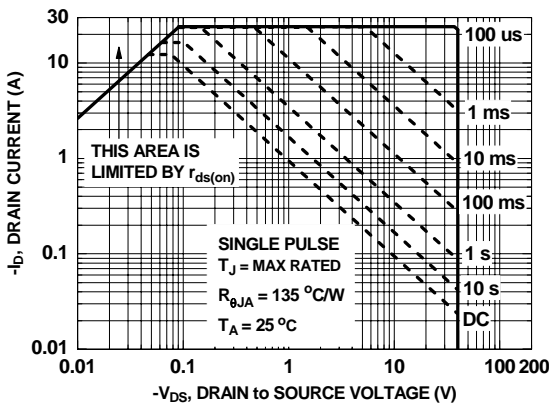
**Figure 22. Capacitance vs Drain to Source Voltage**



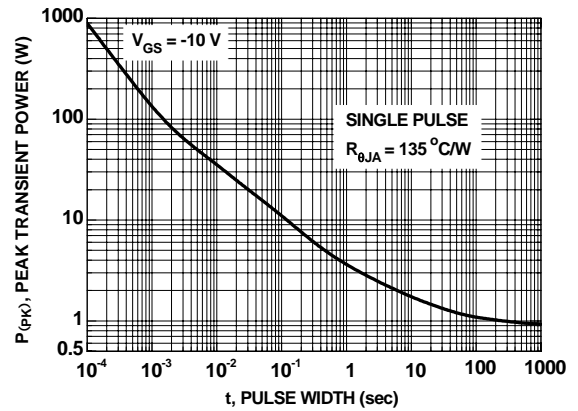
**Figure 23. Unclamped Inductive Switching Capability**



**Figure 24. Maximum Continuous Drain Current vs Ambient Temperature**

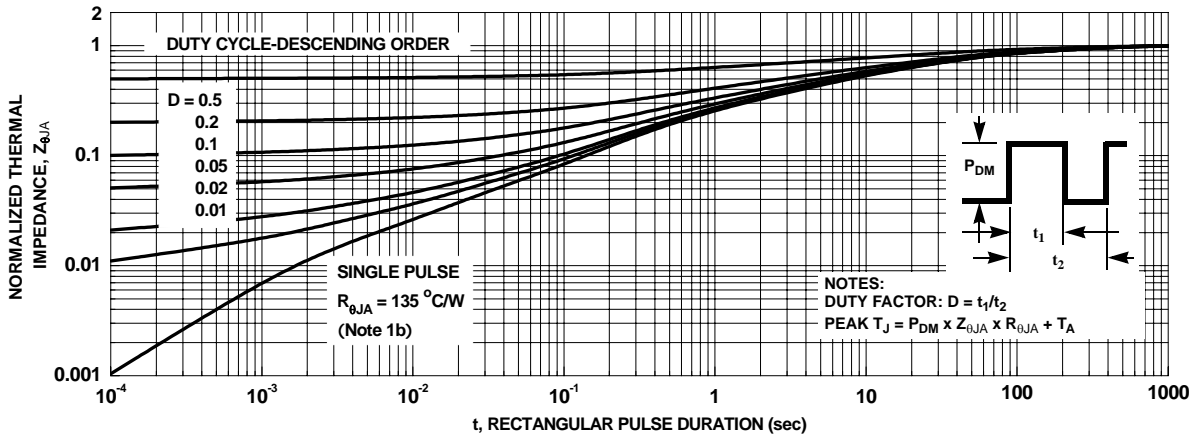


**Figure 25. Forward Bias Safe Operating Area**



**Figure 26. Single Pulse Maximum Power Dissipation**

**Typical Characteristics (Q2 P-Channel)  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted**



**Figure 27. Junction-to-Ambient Transient Thermal Response Curve**





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**Definition of Terms**

Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
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